

Notice of References Cited	Application/Control No. 10/664,931	Applicant(s)/Patent Under Reexamination CHAE ET AL.	
	Examiner Richard H. Kim	Art Unit 2871	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,620,655 b2	09-2003	Ha et al.	438/149
*	B	US-6,297,519 b1	10-2001	Fujikawa et al.	257/59
*	C	US-5,327,001	07-1994	Wakai et al.	257/350
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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